

#### **Description**

The UPA2736GR-E1-AX uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

## S S S G

SOP-8 (SO-8)

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P-Channel MOSFET

#### **General Features**

 $V_{DS} = -30V I_{D} = -15A$ 

 $R_{DS(ON)} < 8.7 \text{m}\Omega$  @  $V_{GS} = 10V$ 

#### **Application**

Battery protection

Load switch

Uninterruptible power supply

#### **Package Marking and Ordering Information**

| Product ID      | Pack        | Brand      | Qty(PCS) |
|-----------------|-------------|------------|----------|
| UPA2736GR-E1-AX | SOP-8(SO-8) | HXY MOSFET | 3000     |

### Absolute Maximum Ratings (T<sub>c</sub>=25°C unless otherwise noted)

| Symbol                               | Parameter   | Rating     | Units |
|--------------------------------------|---|------------|-------|
| V <sub>DS</sub>                      | Drain-Source Voltage  | -30        | V     |
| Vgs                                  | Gate-Source Voltage   | ±20        | V     |
| I <sub>D</sub> @T <sub>A</sub> =25°C | Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> | -15        | А     |
| I <sub>D</sub> @T <sub>A</sub> =70°C | Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> | -11        | А     |
| Ірм                                  | Pulsed Drain Current <sup>2</sup>                             | -56        | А     |
| EAS                                  | Single Pulse Avalanche Energy <sup>3</sup>                    | 151        | mJ    |
| las                                  | Avalanche Current   | -55        | А     |
| P <sub>D</sub> @T <sub>A</sub> =25°C | Total Power Dissipation <sup>4</sup>                          | 1.5        | W     |
| Тѕтс                                 | Storage Temperature Range                                     | -55 to 150 | °C    |
| TJ                                   | Operating Junction Temperature Range                          | -55 to 150 | °C    |
|                                      | Thermal Resistance Junction-Ambient ¹(t≦10s)                  | 40         | °C/W  |
| R <sub>θ</sub> ја                    | Thermal Resistance Junction-Ambient <sup>1</sup>              | 75         | °C/W  |
| R₀Jc                                 | Thermal Resistance Junction-Case <sup>1</sup>                 | 24 °C/W    |       |

#### P-Channel Enhancement Mode MOSFET

#### Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

| Symbol                 | Parameter                                      | Conditions  | Min. | Тур.   | Max. | Unit  |  |
|------------------------|--|---|------|--------|------|-------|--|
| BVDSS                  | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA                              | -30  |        |      | V     |  |
| ∆BVpss/∆TJ             | BV <sub>DSS</sub> Temperature Coefficient      | Reference to 25°C, I <sub>D</sub> =-1mA                                   |      | -0.018 |      | V/°C  |  |
|                        |  | V <sub>GS</sub> =-10V , I <sub>D</sub> =-12A                              |      | 5.8    | 8.7  |       |  |
| RDS(ON)                | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A                             |      | 8.5    | 13.5 | mΩ    |  |
| $V_{GS(th)}$           | Gate Threshold Voltage                         |   | -1.2 |        | -2.5 | V     |  |
| $\triangle V_{GS(th)}$ | V <sub>GS(th)</sub> Temperature Coefficient    | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA                 |      | 5.04   |      | mV/°C |  |
| 1                      |  | V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C        |      |        | -1   |       |  |
| IDSS                   | Drain-Source Leakage Current                   | V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C        |      |        | -5   | uA    |  |
| Igss                   | Gate-Source Leakage Current                    | V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V                               |      |        | ±100 | nA    |  |
| gfs                    | Forward Transconductance                       | V <sub>DS</sub> =-5V , I <sub>D</sub> =-12A                               |      | 25     |      | S     |  |
| Qg                     | Total Gate Charge (-4.5V)                      |   |      | 30     |      |       |  |
| Qgs                    | Gate-Source Charge                             | <br>V <sub>DS</sub> =-15V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-12A |      | 10     |      | nC    |  |
| Q <sub>gd</sub>        | Gate-Drain Charge                              |   |      | 10.4   |      |       |  |
| T <sub>d(on)</sub>     | Turn-On Delay Time                             |   |      | 9.4    |      |       |  |
| Tr                     | Rise Time                                      | V <sub>DD</sub> =-15V,V <sub>GS</sub> =-10V,                              |      | 10.2   |      | ns    |  |
| T <sub>d(off)</sub>    | Turn-Off Delay Time                            | $R_{G}=3.3\Omega$ ,   |      | 117    |      |       |  |
| T <sub>f</sub>         | Fall Time                                      | I <sub>D</sub> =-1A   |      | 24     |      |       |  |
| Ciss                   | Input Capacitance                              |   |      | 3448   |      |       |  |
| Coss                   | Output Capacitance                             | V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz                      |      | 508    |      | pF    |  |
| Crss                   | Reverse Transfer Capacitance                   |   |      | 421    |      | '     |  |
| ls                     | Continuous Source Current <sup>1,5</sup>       |   |      |        | -14  | Α     |  |
| lsм                    | Pulsed Source Current <sup>2,5</sup>           | V <sub>G</sub> =V <sub>D</sub> =0V , Force Current                        |      |        | -56  | Α     |  |
| VsD                    | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C          |      |        | -1.2 | V     |  |
| t <sub>rr</sub>        | Reverse Recovery Time                          | IF=-10A , dI/dt=100A/µs ,   |      | 19.4   |      | nS    |  |
| Qrr                    | Reverse Recovery Charge                        | T <sub>J</sub> =25°C  |      | 9.1    |      | nC    |  |

#### Note:

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%
- 3. The EAS data shows Max. rating . The test condition is  $V_{\text{DD}}$ =-25V,  $V_{\text{GS}}$ =-10V, L=0.1mH,  $I_{\text{AS}}$ =-55A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



#### **Typical Characteristics**

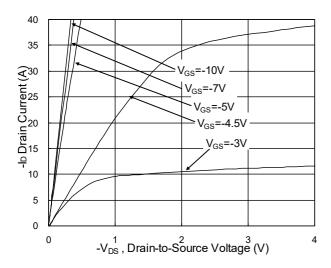


Fig.1 Typical Output Characteristics

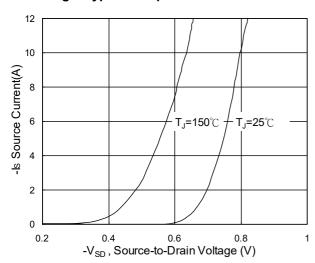


Fig.3 Forward Characteristics Of Reverse

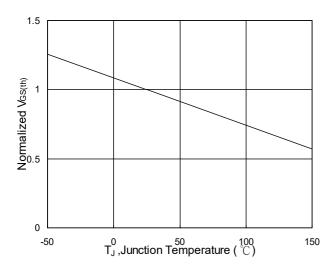


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

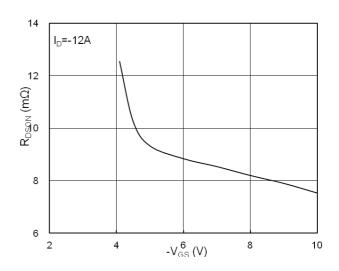


Fig.2 On-Resistance v.s Gate-Source

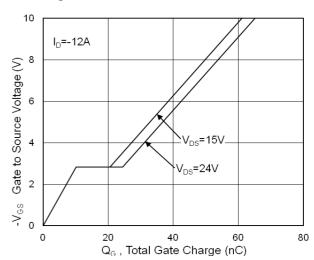


Fig.4 Gate-Charge Characteristics

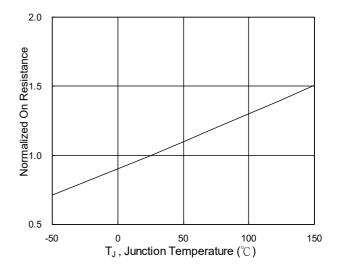
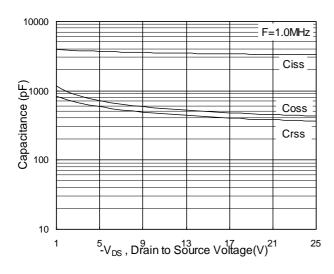


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



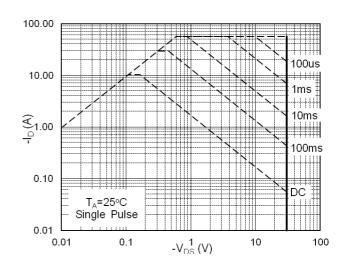


Fig.7 Capacitance

Fig.8 Safe Operating Area

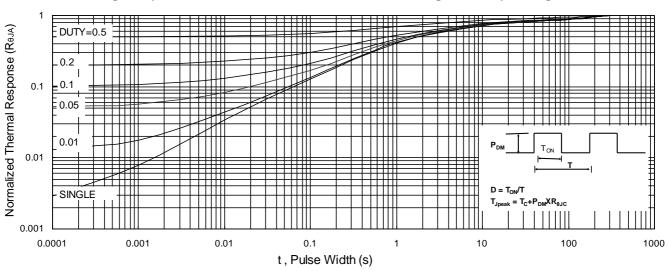


Fig.9 Normalized Maximum Transient Thermal Impedance

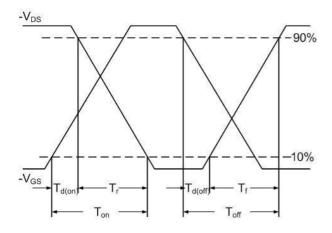


Fig.10 Switching Time Waveform

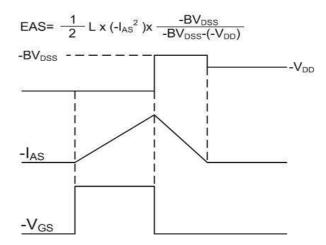
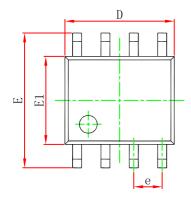
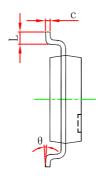


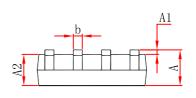
Fig.11 Unclamped Inductive Switching Waveform



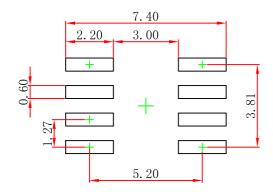
## SOP-8(SO-8) Package Outline Dimensions







| Symbol | Dimensions In Millimeters |        | Dimensions In Inches |        |  |
|--------|---------------------------|--------|----------------------|--------|--|
| Symbol | Min                       | Max    | Min                  | Max    |  |
| A      | 1. 350                    | 1. 750 | 0.053                | 0.069  |  |
| A1     | 0.100                     | 0. 250 | 0.004                | 0.010  |  |
| A2     | 1.350                     | 1.550  | 0.053                | 0.061  |  |
| b      | 0.330                     | 0.510  | 0.013                | 0.020  |  |
| c      | 0.170                     | 0.250  | 0.007                | 0.010  |  |
| D      | 4.800                     | 5.000  | 0.189                | 0.197  |  |
| e      | 1. 270 (BSC)              |        | 0.050 (BSC)          |        |  |
| E      | 5.800                     | 6. 200 | 0. 228               | 0. 244 |  |
| E1     | 3.800                     | 4.000  | 0.150                | 0. 157 |  |
| L      | 0.400                     | 1. 270 | 0.016                | 0.050  |  |
| θ      | 0°                        | 8°     | 0°                   | 8°     |  |



- Note:
  1.Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
  3.The pad layout is for reference purposes only.



#### P-Channel Enhancement Mode MOSFET

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